SDAS053B - APRIL 1982 - REVISED JANUARY 1995

- 'AS1034A Offer High Capacitive-Drive Capability
- Noninverting Drivers
- Package Options Include Plastic Small-Outline (D) Packages, Ceramic Chip Carriers (FK), and Standard Plastic (N) and Ceramic (J) 300-mil DIPs

description

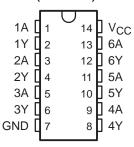
These devices contain six independent noninverting drivers. They perform the Boolean function Y = A.

The SN54ALS1034 and SN54AS1034A are characterized for operation over the full military temperature range of -55°C to 125°C. The SN74ALS1034 and SN74AS1034A are characterized for operation from 0°C to 70°C.

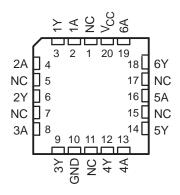
FUNCTION TABLE (each buffer)

INPUT A	OUTPUT Y
Н	Н
L	L

SN54ALS1034, SN54AS1034A . . . J PACKAGE SN74ALS1034, SN74AS1034A . . . D OR N PACKAGE (TOP VIEW)



SN54ALS1034, SN54AS1034A . . . FK PACKAGE (TOP VIEW)



NC - No internal connection

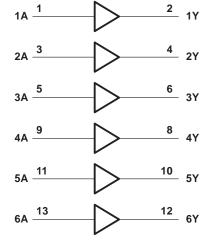
logic symbol†

1A	1	N	2	1Y
	3		4	
2A	5		6	2Y
3A	9		8	3Y
4A	11		10	4Y
5A	13		12	5Y
6A				6Y

[†] This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

Pin numbers shown are for the D, J, and N packages.

logic diagram (positive logic)



SN54ALS1034, SN54AS1034A, SN74ALS1034, SN74AS1034A HEX DRIVERS

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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage, V _{CC}	7 V
Input voltage, V _I	7 V
Operating free-air temperature range, T _A : SN54ALS1034	55°C to 125°C
SN74ALS1034	0°C to 70°C
Storage temperature range	65°C to 150°C

recommended operating conditions

		SN54ALS1034			SN	UNIT		
		MIN	NOM	MAX	MIN	NOM	MAX	UNIT
Vcc	Supply voltage	4.5	5	5.5	4.5	5	5.5	V
VIH	High-level input voltage	2			2			V
VIL	Low-level input voltage			0.7			8.0	V
IOH	High-level output current		-12				-15	mA
loL	Low-level output current			12			24	mA
TA	Operating free-air temperature	-55		125	0		70	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

DADAMETED	TEST CONDITIONS		SN!	SN54ALS1034			SN74ALS1034			
PARAMETER	1531 (1	TEST CONDITIONS		TYP [‡]	MAX	MIN	TYP [‡]	MAX	UNIT	
VIK	V _{CC} = 4.5 V,	$I_{I} = -18 \text{ mA}$			-1.2			-1.2	V	
	$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V},$	$I_{OH} = -0.4 \text{ mA}$	V _{CC} -2	2		V _{CC} -2	!			
Vari		$I_{OH} = -3 \text{ mA}$	2.4	3.2		2.4	3.2		V	
VOH	$V_{CC} = 4.5 V$	$I_{OH} = -12 \text{ mA}$	2						V	
		$I_{OH} = -15 \text{ mA}$				2				
	Vcc = 4.5 V	I _{OL} = 12 mA		0.25	0.4				V	
VOL	VCC = 4.5 V	I _{OL} = 24 mA					0.35	0.5	V	
lį	$V_{CC} = 5.5 V,$	V _I = 7 V			0.1			0.1	mA	
lіН	$V_{CC} = 5.5 V$,	V _I = 2.7 V			20			20	μΑ	
Ι _{ΙL}	$V_{CC} = 5.5 V$,	V _I = 0.4 V			-0.1			-0.1	mA	
ΙΟ [§]	V _{CC} = 5.5 V,	V _O = 2.25 V	-20		-112	-30		-112	mA	
ICCH	V _{CC} = 5.5 V,	V _I = 4.5 V		3	6		3	6	mA	
ICCL	V _{CC} = 5.5 V,	V _I = 0		8	14		8	14	mA	

[‡] All typical values are at $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$.



[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

[§] The output conditions have been chosen to produce a current that closely approximates one half of the true short-circuit output current, IOS.

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switching characteristics (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	C _L R _L T _A	= 50 pF, = 500 Ω = MIN to	MAXT		UNIT
			SN54AL	.S1034	SN74AL	S1034	
			MIN	MAX	MIN	MAX	
^t PLH	٨	V	1	11	1	8	ns
t _{PHL}	A	1	1	13	1	8	115

[†] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)‡

Supply voltage, V _{CC}	 7 V
Input voltage, V _I	 7 V
Operating free-air temperature range, T _A : SN54AS1034A	
SN74AS1034A	 0°C to 70°C
Storage temperature range	 -65°C to 150°C

[‡] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

recommended operating conditions§

		SN54AS1034A			SN7	UNIT		
		MIN	NOM	MAX	MIN	NOM	MAX	UNII
VCC	Supply voltage	4.5	5	5.5	4.5	5	5.5	V
VIH	High-level input voltage	2			2			V
V _{IL}	Low-level input voltage			0.8			0.8	V
ІОН	High-level output current			-40			-48	mA
loL	Low-level output current			40			48	mA
TA	Operating free-air temperature	-55		125	0		70	°C

[§] These high sink- or source-current devices are not recommended for use above 40 MHz.



SN54ALS1034, SN54AS1034A, SN74ALS1034, SN74AS1034A HEX DRIVERS

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electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS		SN5	4AS103	4A	SN7	'4AS103	4A	UNIT
PARAMETER	1531 (4	TEST CONDITIONS		TYP [†]	MAX	MIN	TYP	MAX	UNII
VIK	V _{CC} = 4.5 V,	I _I = -18 mA			-1.2			-1.2	V
	$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V},$	$I_{OH} = -2 \text{ mA}$	V _{CC} -2			V _{CC} -2	}		
\/a		$I_{OH} = -3 \text{ mA}$	2.4	3.2		2.4	3.2		V
VOH	$V_{CC} = 4.5 V$	$I_{OH} = -40 \text{ mA}$	2						V
		$I_{OH} = -48 \text{ mA}$				2			
VoL	V _{CC} = 4.5 V	$I_{OL} = 40 \text{ mA}$		0.25	0.5				V
VOL	VCC = 4.5 V	$I_{OL} = 48 \text{ mA}$					0.35	0.5	V
ΙĮ	$V_{CC} = 5.5 \text{ V},$	V _I = 7 V			0.1			0.1	mA
lін	$V_{CC} = 5.5 \text{ V},$	$V_1 = 2.7 \ V$			20			20	μΑ
I _{IL}	$V_{CC} = 5.5 V,$	V _I = 0.4 V			-0.5			-0.5	mA
I _O [‡]	$V_{CC} = 5.5 V,$	V _O = 2.25 V	-50		-200	-50		-200	mA
Іссн	V _{CC} = 5.5 V,	V _I = 4.5 V		9	15		9	15	mA
ICCL	V _{CC} = 5.5 V,	V _I = 0		21	35		21	35	mA

[†] All typical values are at $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$.

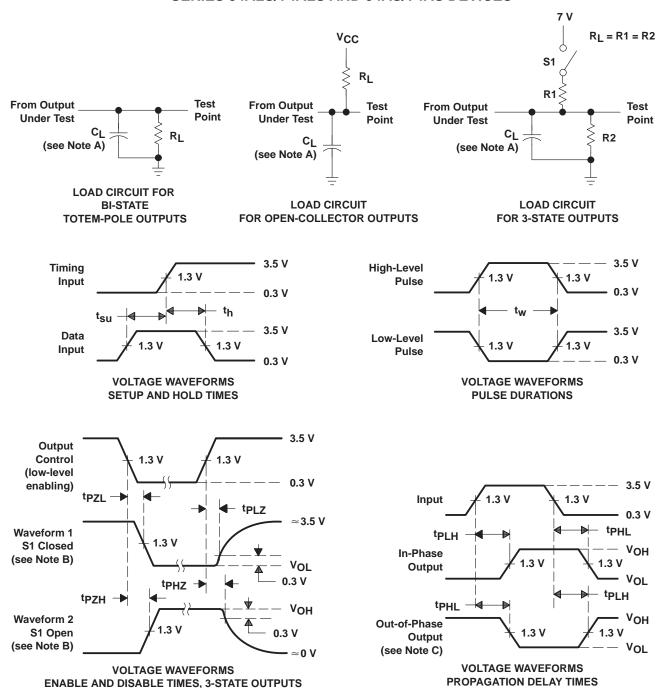
switching characteristics (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	C _L R _L T _A	V_{CC} = 4.5 V to 5.5 V, C_L = 50 pF, R_L = 500 Ω, T_A = MIN to MAX§ SN54AS1034A SN74AS1034A				
			MIN	MAX	MIN	MAX	1	
t _{PLH}	۸	V	1	6.5	1	6	ns	
^t PHL	А	1	1	6.5	1	6	115	

[§] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

[‡] The output conditions have been chosen to produce a current that closely approximates one half of the true short-circuit output current, IOS.

PARAMETER MEASUREMENT INFORMATION SERIES 54ALS/74ALS AND 54AS/74AS DEVICES



NOTES: A. C_L includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. When measuring propagation delay items of 3-state outputs, switch S1 is open.
- D. All input pulses have the following characteristics: PRR \leq 1 MHz, $t_r = t_f = 2$ ns, duty cycle = 50%.
- E. The outputs are measured one at a time with one transition per measurement.

Figure 1. Load Circuits and Voltage Waveforms



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